Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/716,521	LIN, YUAN	
Examiner	Art Unit	
James W. Cranson	2875	

SEARCHED				
Class	Subclass	Date	Examiner	
362	252	10/10/2005	JWC	
362	249	10/10/2005	JWC	
362	219	10/10/2005	JWC	
362	391	10/10/2005	JWC	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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